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26 4A4

25 30E

4Y4 23

 $4\overline{OE}$

24

 Members of the Texas Instruments Widebus[™] Family 	SN54ABT16241 WD PACKAGE SN74ABT16241A DGG, DGV, OR DL PAC (TOP VIEW)	KAGE
 State-of-the-Art EPIC-IIB[™] BiCMOS Design Significantly Reduces Power Dissipation 		
 ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V 	1Y1 2 47 11A1 1Y2 3 46 11A2	
Using Machine Model (C = 200 pF, R = 0)	GND 4 45 GND	
Latch-Up Performance Exceeds 500 mA Per	1Y3 5 44 1A3	
 JEDEC Standard JESD-17 Typical V_{OLP} (Output Ground Bounce) < 1 V 	1Y4 0 6 43 0 1A4 V _{CC} 0 7 42 0 V _{CC}	
at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$	2Y1 🛛 8 41 🗍 2A1	
• Distributed V _{CC} and GND Pin Configuration	2Y2 0 9 40 2A2 GND 10 39 GND	
Minimizes High-Speed Switching Noise	2Y3 11 38 2A3	
 Flow-Through Architecture Optimizes PCB Layout 	2Y4 12 37 2A4	
 High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL}) 	3Y1 [] 13 36 [] 3A1 3Y2 [] 14 35 [] 3A2	
 Package Options Include Plastic 300-mil 	GND [15 34] GND	
Shrink Small-Outline (DL), Thin Shrink	3Y3 🛛 16 🛛 33 🗋 3A3	
Small-Outline (DGG), and Thin Very	3Y4 17 32 3A4	
Small-Outline (DGV) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package	V _{CC} [] 18 31 [] V _{CC} 4Y1 [] 19 30 [] 4A1	
Using 25-mil Center-to-Center Spacings	4Y2 20 29 4A2	
-	GND 21 28 GND	
description	4Y3 22 27 4A3	

description

The SN54ABT16241 and SN74ABT16241A are 16-bit buffers and line drivers designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

These devices can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. These devices provide true outputs and complementary output-enable (OE and \overline{OE}) inputs.

To ensure the high-impedance state during power up or power down, $\overline{\mathsf{OE}}$ should be tied to V $_{\mathsf{CC}}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver. OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

The SN54ABT16241 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ABT16241A is characterized for operation from -40°C to 85°C.



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SN54ABT16241, SN74ABT16241A 16-BIT BUFFERS/DRIVERS WITH 3-STATE OUTPUTS SCBS096F – FEBRUARY 1991 – REVISED JANUARY 1997

FUNCTION TABLES

INPU ⁻	TS	OUTPUTS
1 <mark>0E</mark> , 40E	1A, 4A	1Y, 4Y
L	Н	Н
L	L	L
н	Х	Z

INPU	тѕ	OUTPUTS
20E, 30E	2A, 3A	2Y, 3Y
Н	Н	Н
н	L	L
L	Х	Z

logic symbol[†]

					1	
1 <mark>0E</mark>	1	EN1				
20E	48	EN2				
30E	25	EN3				
	24					
4OE		EN4				
1A1	47	┍───	1	1∇	2	1Y1
	46	<u> </u>		1 v	3	
1A2	44				5	1Y2
1A3	43				6	1Y3
1A4	41			• -	8	1Y4
2A1	40	┣───	1	2 ▽	9	2Y1
2A2	38				11	2Y2
2A3	37				12	2Y3
2A4	36	╞───			13	2Y4
3A1	35	 	1	3∇	14	3Y1
3A2	33				16	3Y2
3A3	32				17	3Y3
3A4	30				19	3Y4
4A1			1	4 ▽		4Y1
4A2	29	-			20	4Y2
4A3	27	-			22	4Y3
4A4	26				23	4Y4
		L			1	

 † This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, Vo	–0.5 V to 5.5 V
Current into any output in the low state, IO: SN54ABT16241	96 mA
SN74ABT16241A	128 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	
Package thermal impedance, θ_{JA} (see Note 2): DGG package	89°C/W
DGV package	93°C/W
DL package	94°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.



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recommended operating conditions (see Note 3)

			SN54AB	Г16241	SN74ABT	16241A	UNIT
			MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	/IH High-level input voltage		2		2		V
VIL	Low-level input voltage			0.8		0.8	V
VI	Input voltage		0	VCC	0	VCC	V
ЮН	High-level output current			-24		-32	mA
IOL	Low-level output current			48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
Т _А	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	METER	TEST CO	NDITIONS	Г	A = 25°C	;	SN54AB	16241	SN74ABT	6241A	UNIT	
PARAI	VIETER	IESI CO	NDITIONS	MIN	TYP [†]	MAX	MIN	MAX	MIN	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = -18 mA			-1.2		-1.2		-1.2	V	
		V _{CC} = 4.5 V,	I _{OH} = -3 mA	2.5			2.5		2.5			
Vari		V _{CC} = 5 V,	I _{OH} = -3 mA	3			3		3		V	
VOH		V _{CC} = 4.5 V	I _{OH} = -24 mA	2			2				v	
		VCC = 4.5 V	I _{OH} = -32 mA	2*					2			
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55		0.55			V	
VOL		VCC = 4.5 V	I _{OL} = 64 mA			0.55*				0.55	v	
V _{hys}					100						mV	
կ		V _{CC} = 5.5 V,	$V_I = V_{CC}$ or GND			±1		±1		±1	μA	
IOZH		V _{CC} = 5.5 V,	V _O = 2.7 V			10		10		10	μA	
IOZL		V _{CC} = 5.5 V,	$V_{O} = 0.5 V$			-10		-10		-10	μA	
loff		$V_{CC} = 0,$	VI or VO \leq 4.5 V			±100				±100	μA	
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50		50		50	μΑ	
10‡		V _{CC} = 5.5 V,	V _O = 2.5 V	-50	-100	-180	-50	-180	-50	-180	mA	
		V _{CC} = 5.5 V,	Outputs high			3*		2		3		
ICC		$I_{O} = 0,$	Outputs low			34* 32			34	mA		
		$V_{I} = V_{CC}$ or GND	Outputs disabled			3*		2		3		
	Data $V_{CC} = 5.5 V$, One input at 3.4 V,		Outputs enabled			1		1.5		1		
∆ICC§	inputs	Other inputs at V _{CC} or GND	Outputs disabled			0.05		1		0.05	mA	
	Control $V_{CC} = 5.5 \text{ V}$, One inp inputs Other inputs at V_{CC} c					1.5		1.5		1.5		
Ci	-	V _I = 2.5 V or 0.5 V			3.5						pF	
Co		$V_{O} = 2.5 \text{ V or } 0.5 \text{ V}$			7.5						pF	

* On products compliant to MIL-PRF-38535, this parameter does not apply.

[†] All typical values are at V_{CC} = 5 V.

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V ₍ Т,	CC = 5 V A = 25°C	!, ;;	MIN MAX		UNIT
		MIN	TYP	MAX				
^t PLH	A	V	0.9	2.7	3.4	0.9	3.8	ns
^t PHL		Ι	0.9	2.7	3.9	0.9	4.6	115
^t PZH	OE or OE	v	1.2	3.3	4.2	1.2	5.1	ns
^t PZL		Ι	1.3	3.4	5.9	1.3	7	115
^t PHZ	05 05	V	1.5	4.1	5.5	1.5	7	ns
^t PLZ		I	1.7	3.6	5.1	1.7	5.7	115

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER FROM (INPUT) (OU								
			V _{CC} = 5 V, T _A = 25°C			MIN	МАХ	UNIT
		MIN	TYP	MAX				
^t PLH	A	v	1	2.7	3.4	1	3.7	ns
^t PHL			1	2.7	3.9	1	4.5	115
^t PZH		v	1.2	3.3	4.2	1.2	5	ns
^t PZL	OE or OE	T	1.3	3.4	5.9	1.3	6.9	115
^t PHZ	OE or OE	v	1.5	4.1	5.2	1.5	6.2	ns
^t PLZ			1.7	3.6	5.1	1.7	5.6	115



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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